## Application/Control No. Applicant(s)/Patent Under Reexamination ANDO ET AL. Examiner John Hoffmann Application/Control No. Applicant(s)/Patent Under Reexamination ANDO ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

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## FOREIGN PATENT DOCUMENTS

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## **NON-PATENT DOCUMENTS**

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	U /	′ KATO et al, (The USPTO's translation of JP 1-188479)			
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